

N-Channel Enhancement Mode Power MOSFET

MTN3205E3

BV_{DSS}	55V
I_D	128A
$R_{DSON(TYP)} @ V_{GS}=10V, I_D=62A$	3.9 mΩ
$R_{DSON(TYP)} @ V_{GS}=6V, I_D=30A$	4.5 mΩ

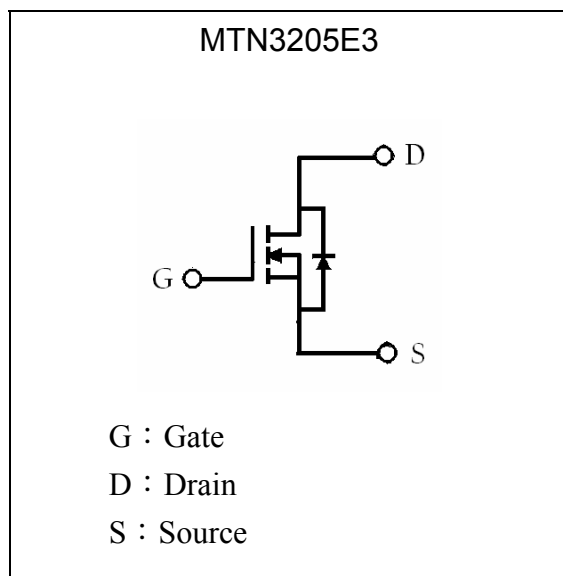
Description

The MTN3205E3 is a N-channel enhancement-mode MOSFET, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness. The TO-220 package is universally preferred for all commercial-industrial applications

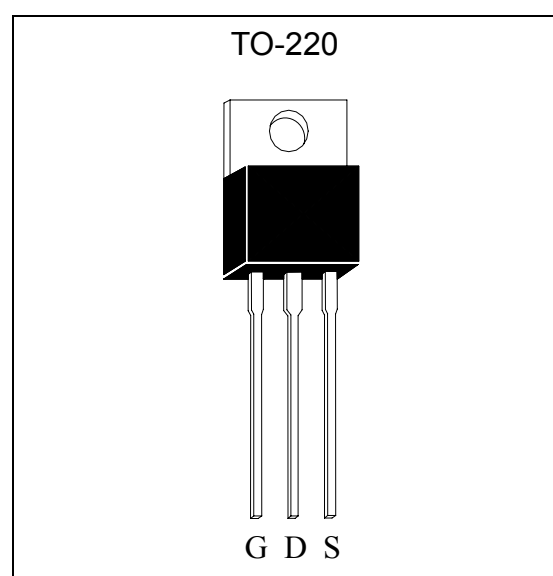
Features

- Low On Resistance
- Simple Drive Requirement
- Low Gate Charge
- Fast Switching Characteristic
- Pb-free lead plating and RoHS compliant package

Symbol



Outline



**Absolute Maximum Ratings** ($T_c=25^\circ\text{C}$)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage (Note 1)	V_{DS}	55	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current @ $T_c=25^\circ\text{C}$, $V_{GS}=10\text{V}$ (silicon limit)	I_D	128*	A
Continuous Drain Current @ $T_c=100^\circ\text{C}$, $V_{GS}=10\text{V}$ (silicon limit)		90*	
Continuous Drain Current @ $T_c=25^\circ\text{C}$, $V_{GS}=10\text{V}$ (package limit)		75	
Pulsed Drain Current (Note 2)	I_{DM}	390*	
Single Pulse Avalanche Energy (Note 3)	E_{AS}	343	mJ
Repetitive Avalanche Energy (Note 2)	E_{AR}	20	
Peak Diode Recovery dv/dt (Note 4)	dv/dt	4.5	V/ns
ESD susceptibility (Note 5)		2000	V
Maximum Temperature for Soldering @ Lead at 0.125in(3.175mm) from case for 10 seconds	T_L	300	$^\circ\text{C}$
Total Power Dissipation ($T_c=25^\circ\text{C}$)	P_D	200	W
Linear Derating Factor above 25°C		1.33	W/ $^\circ\text{C}$
Operating Junction and Storage Temperature	T_j, T_{stg}	-55~+175	$^\circ\text{C}$

*Drain current limited by maximum junction temperature

- Note : 1. $T_j=+25^\circ\text{C}$ to $+150^\circ\text{C}$.
 2. Repetitive rating; pulse width limited by maximum junction temperature.
 3. $I_{AS}=70\text{A}$, $V_{DD}=25\text{V}$, $L=0.14\text{mH}$, $R_G=25\Omega$, starting $T_j=+25^\circ\text{C}$.
 4. $I_{SD}=40\text{A}$, $dI/dt<100\text{A}/\mu\text{s}$, $V_{DD}<BV_{DSS}$, $T_j=+150^\circ\text{C}$.
 5. Human body model, $1.5\text{k}\Omega$ in series with 100pF .

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{th,j-c}$	0.75	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction-to-ambient, max	$R_{th,j-a}$	62	$^\circ\text{C}/\text{W}$



Characteristics (Tj=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	55	-	-	V	V _{GS} =0, I _D =250μA
V _{GS(th)}	2.0	2.8	4.0		V _{DS} = V _{GS} , I _D =250μA
*G _{FS}	-	40	-	S	V _{DS} =10V, I _D =40A
I _{GSS}	-	-	±100	nA	V _{GS} =±20
I _{DSS}	-	-	1	μA	V _{DS} =55V, V _{GS} =0
	-	-	10		V _{DS} =44V, V _{GS} =0, Tj=125°C
*R _{DS(ON)}	-	3.9	8	mΩ	V _{GS} =10V, I _D =62A
	-	4.5	14		V _{GS} =6V, I _D =30A
Dynamic					
*Q _g	-	91	-	nC	I _D =62A, V _{DD} =44V, V _{GS} =10V
*Q _{gs}	-	28	-		
*Q _{gd}	-	29	-		
*t _{d(ON)}	-	25	-	ns	V _{DD} =28V, I _D =62A, V _{GS} =10V, R _G =4.5Ω
*t _r	-	116	-		
*t _{d(OFF)}	-	78	-		
*t _f	-	53	-		
C _{iss}	-	5409	-	pF	V _{GS} =0V, V _{DS} =25V, f=1MHz
C _{oss}	-	580	-		
C _{rss}	-	460	-		
Source-Drain Diode					
*I _S	-	-	128	A	
*I _{SM}	-	-	390		
*V _{SD}	-	0.91	1.3	V	I _S =62A, V _{GS} =0V
*t _{rr}	-	110	-	ns	V _{GS} =0, I _F =62A, dI/dt=100A/μs
*Q _{rr}	-	240	-	nC	

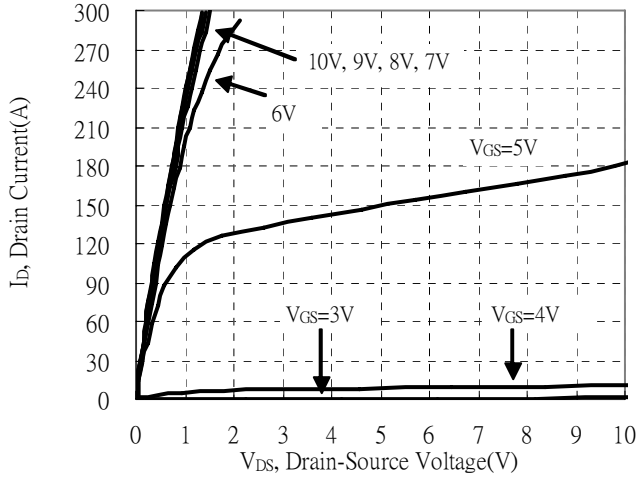
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

Ordering Information

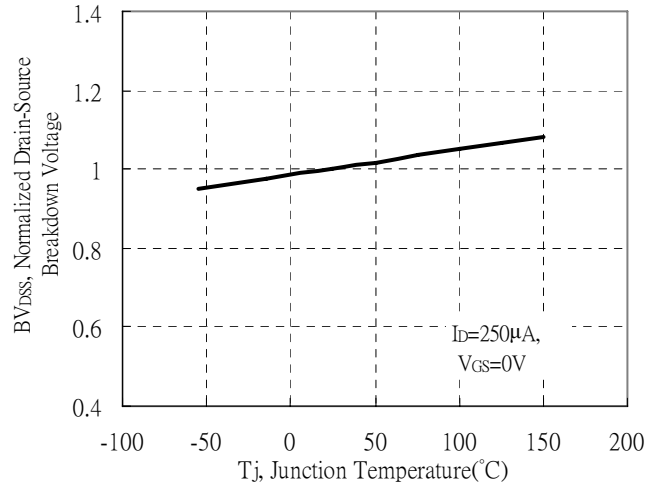
Device	Package	Shipping
MTN3205E3-0-UB-S	TO-220 (Pb-free lead plating and RoHS compliant package)	50 pcs/tube, 20 tubes/box, 4 boxes / carton

Typical Characteristics

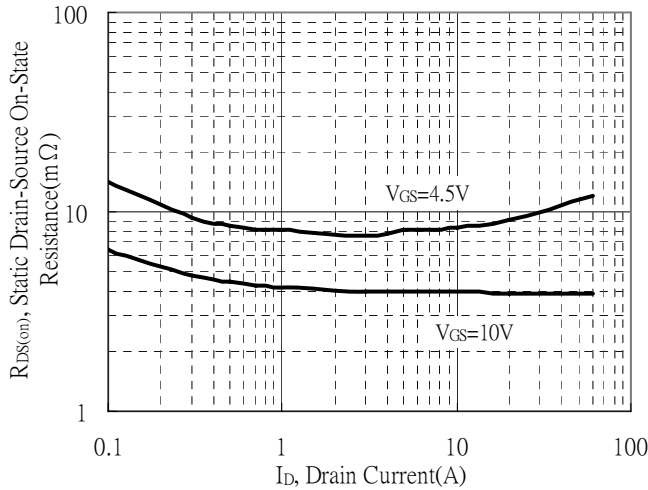
Typical Output Characteristics



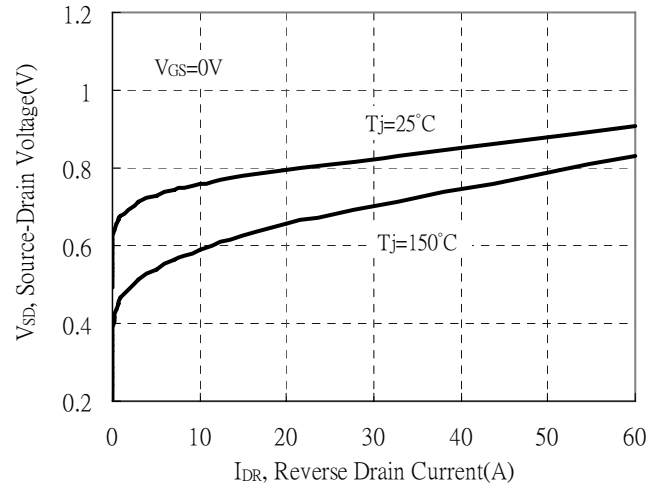
Brekdown Voltage vs Ambient Temperature



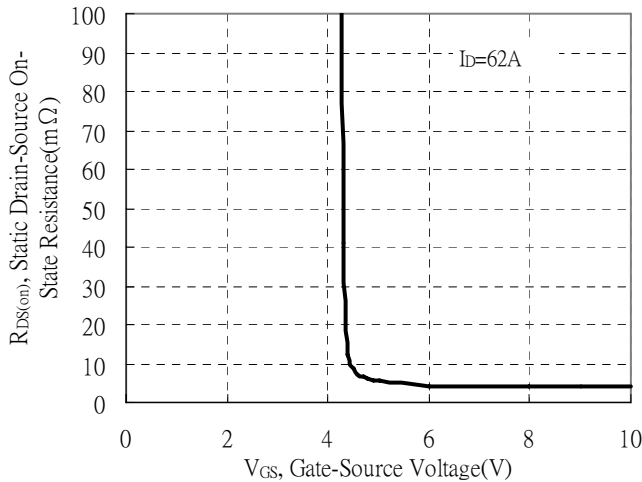
Static Drain-Source On-State resistance vs Drain Current



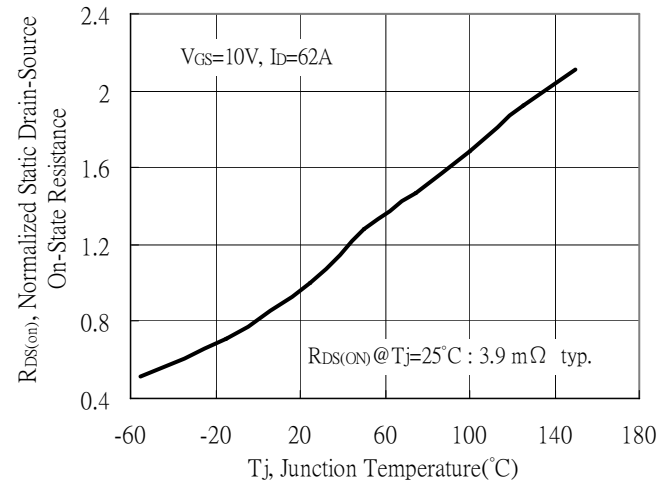
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

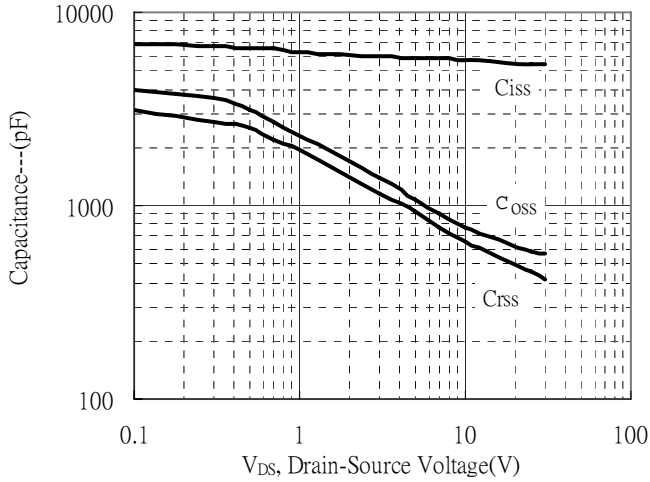


Drain-Source On-State Resistance vs Junction Temperature

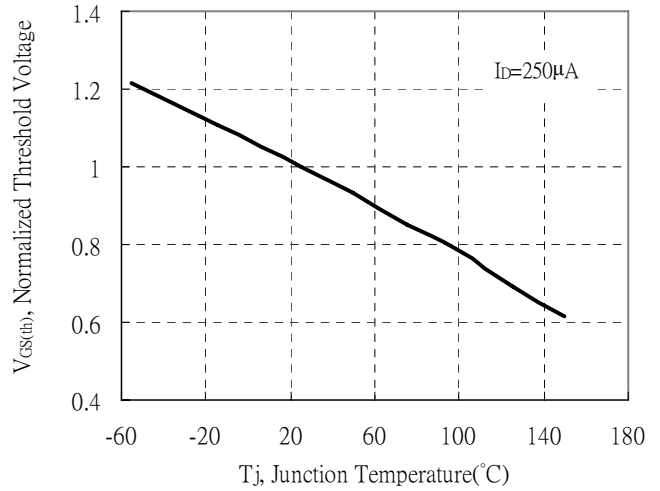


Typical Characteristics(Cont.)

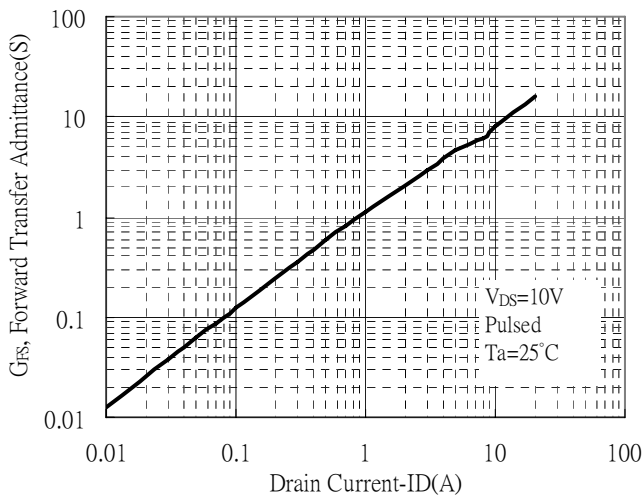
Capacitance vs Drain-to-Source Voltage



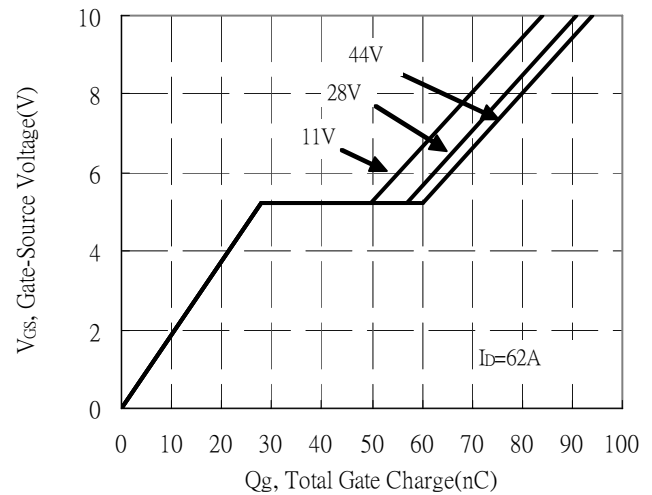
Threshold Voltage vs Junction Temperature



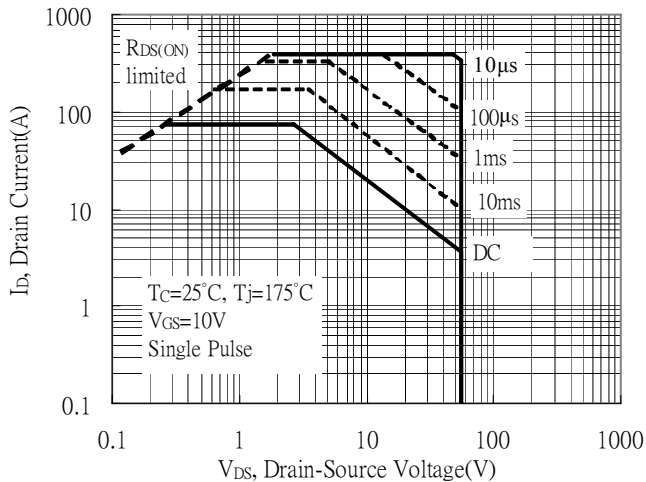
Forward Transfer Admittance vs Drain Current



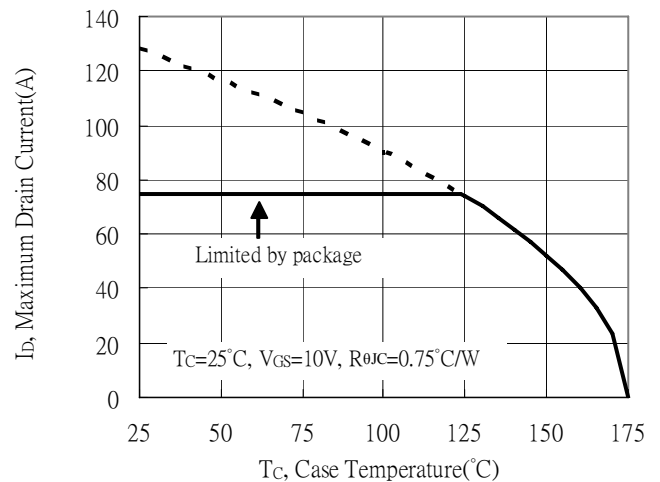
Gate Charge Characteristics



Maximum Safe Operating Area

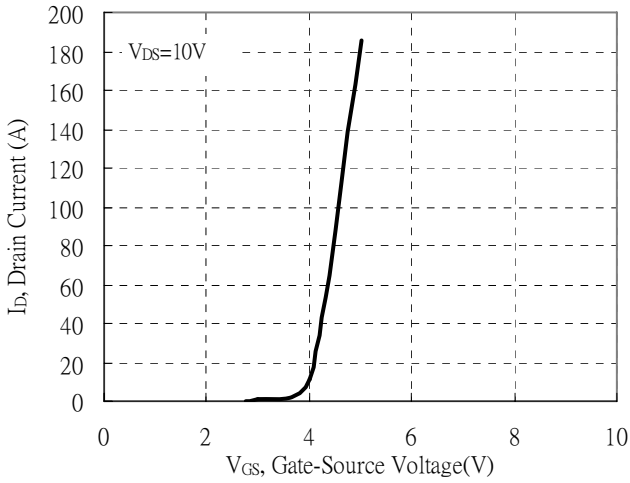


Maximum Drain Current vs Case Temperature

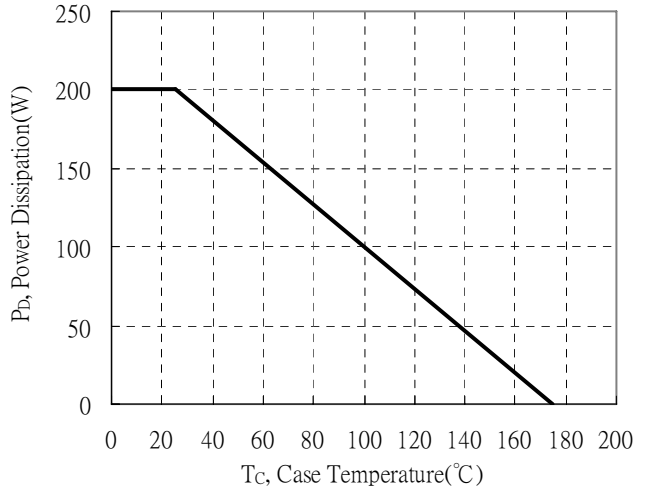


Typical Characteristics(Cont.)

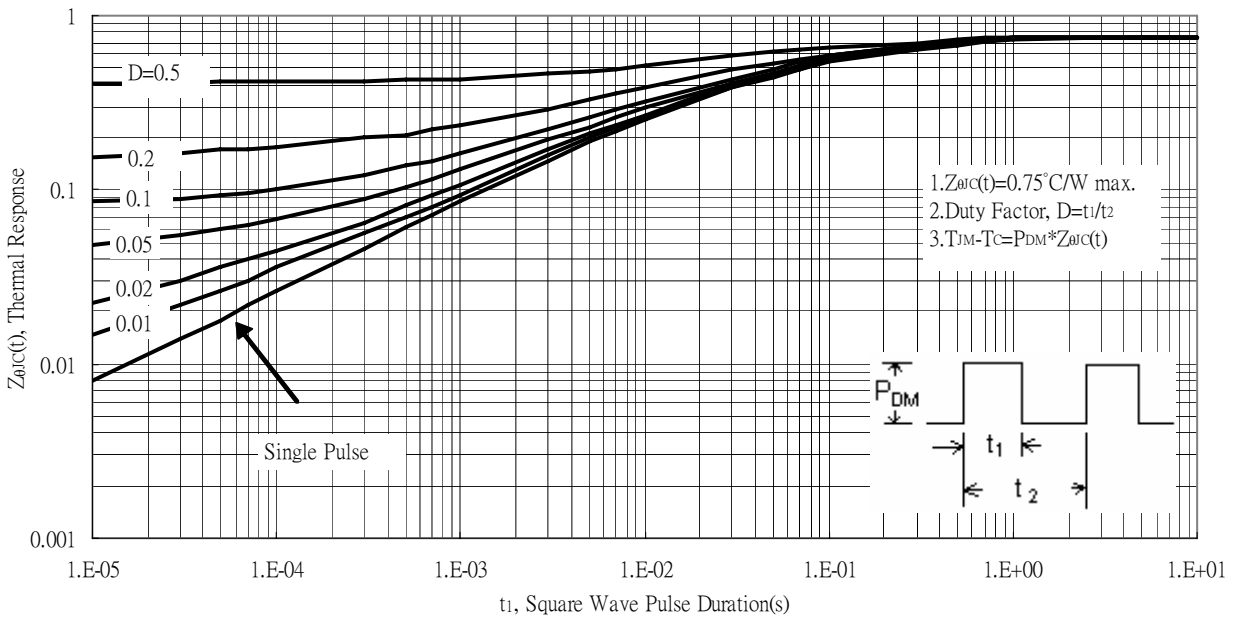
Typical Transfer Characteristics



Power Derating Curve



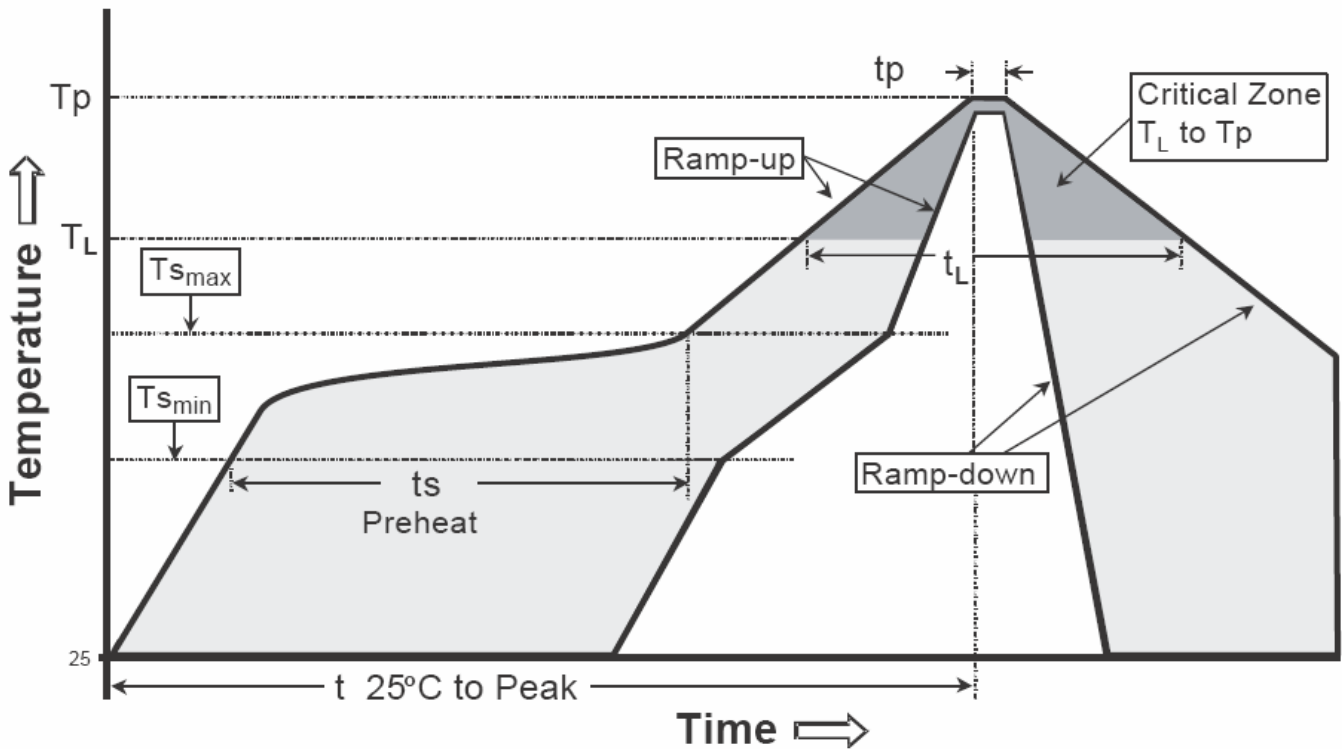
Transient Thermal Response Curves



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

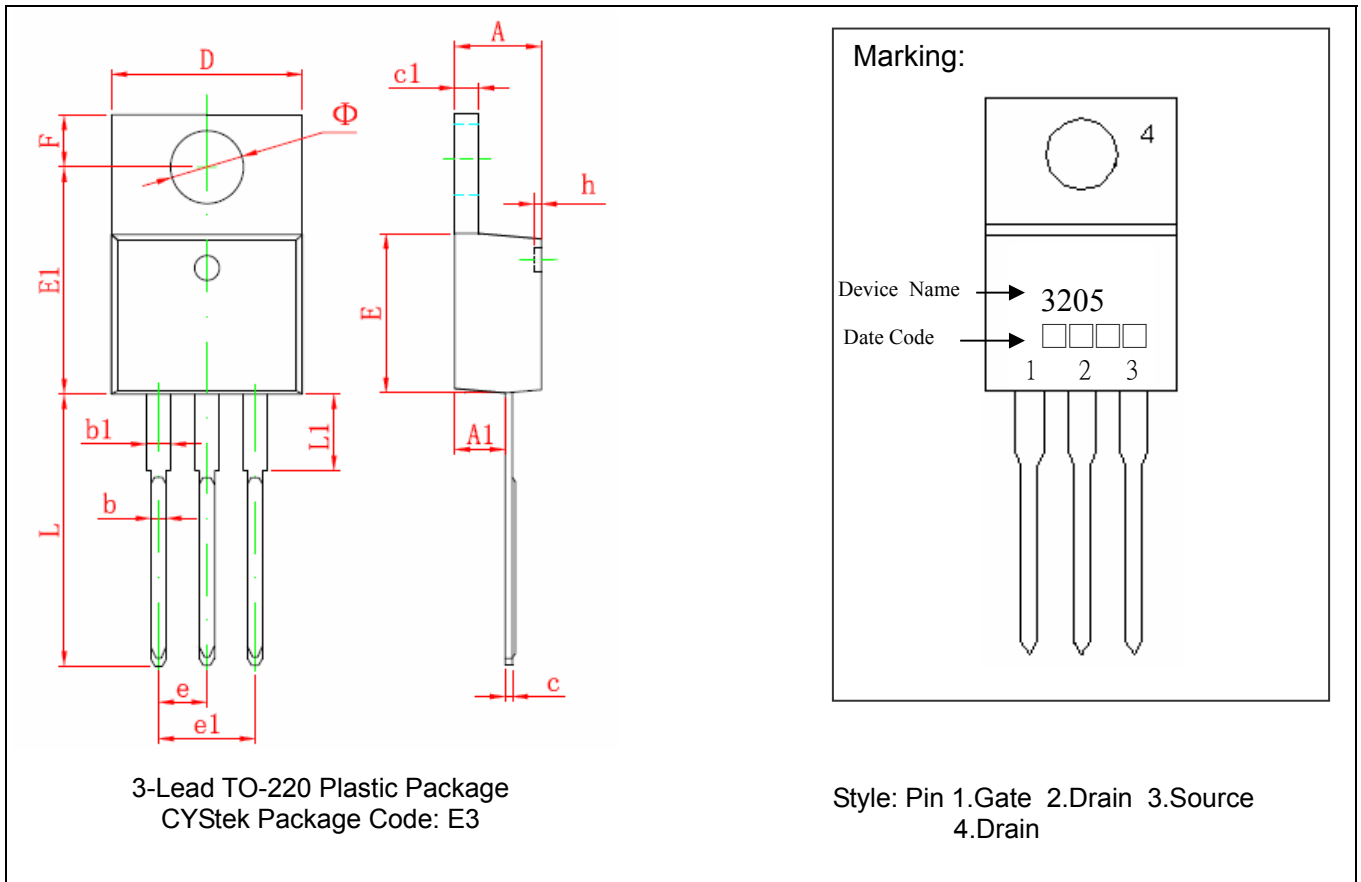
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (TL)	183°C	217°C
- Time (tL)	60-150 seconds	60-150 seconds
Peak Temperature(TP)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

TO-220 Dimension



*: Typical

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	4.470	4.670	0.176	0.184	E1	12.060	12.460	0.475	0.491
A1	2.520	2.820	0.099	0.111	e	2.540*		0.100*	
b	0.710	0.910	0.028	0.036	e1	4.980	5.180	0.196	0.204
b1	1.170	1.370	0.046	0.054	F	2.590	2.890	0.102	0.114
c	0.310	0.530	0.012	0.021	h	0.000	0.300	0.000	0.012
c1	1.170	1.370	0.046	0.054	L	13.400	13.800	0.528	0.543
D	10.010	10.310	0.394	0.406	L1	3.560	3.960	0.140	0.156
E	8.500	8.900	0.335	0.350	Φ	3.735	3.935	0.147	0.155

Notes: 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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